

M550 Impedance Calibrator

Model M550 Impedance calibrator is designed for calibration of LCR meters. The calibrator consists of several banks of resistance, capacitance and inductance standards of fix decimal values. Total range cover values from 0.1 Ohm to 100 MOhm, 10 pF to 100 μ F and 10 μ H to 10 H. Calibrator offers four-pair terminal and four terminal coaxial output connectors for calibration of precise and wide range LCR meters, four-terminal and two-terminal non-coaxial output connectors for calibration of simple LCR meters and elder LCR meters.



Basic applicable frequency range is from 20 Hz to 1 MHz in coaxial mode, and to 100 kHz in non-coaxial mode. Calibration memory contains both complex parameters of partial standards. The calibration values can be displayed in wide range of frequently used pairs of complex impedance and admittance. Either parallel or series equivalent model can be selected. The calibrator is equipped with reference positions OPEN and SHORT terminals for easy elimination of test cables influence.

Part of the calibrator is built in level meter of voltage and frequency of test signal which is generated by tested LCR meter during calibration.

M550 calibrator is equipped with large size colour LCD display. It can be controlled either manually from front panel keypad or remotely using GPIB or RS232 interface. M550 is compatible with Meatest automation software CALIBER.



Specification summary

| | | |
|---|---|---|
| Modes: | 4TP four pair terminal 4W four terminal 2W two terminal | R/L/C coaxial output for coaxial four terminal and four pair terminal applications R/C non-coaxial for four wire applications R/C non-coaxial for two wire applications |
| Output terminals | 4 x BNC connectors for coaxial output (4TP) 4 x banana terminal for non-coaxial output (2W/4W) | |
| Frequency range Reference positions: | 20Hz to 1 MHz SHORT, OPEN | |

Resistance

| | | |
|----------------------------|--|--|
| Range | 0.1 Ω to 100 MΩ 0.1 Ω to 100 MΩ 1 Ω to 10 MΩ | fix decimal values in 4TP mode fix decimal values in 4W mode fix decimal values in 2W mode |
| Deviation to nominal value | 0.10 % to 10 % depending on value and mode | |
| Calibration uncertainty | 0.02 % to 1 % at 1 kHz depending on value and mode | |
| Temperature coefficient | 2 to 25 ppm/°C | |
| Displayed parameter pairs | Z/ε, Y/ε, Rs/Ls, Rs/Cs, Rp/Cp, Rp/Lp, R/X, G/B | |

Capacitance

| | | |
|----------------------------|---|--|
| Range | 10 pF to 100 μF 100 pF to 100 μF 100 pF to 100 μF | fix decimal values in 4TP mode fix decimal values in 4W mode fix decimal values in 2W mode |
| Deviation to nominal value | < 5% | |
| Calibration uncertainty | 0.05 % to 5 % at 1 kHz depending on value and mode | |
| Temperature coefficient | 30 to 100 ppm/°C | |
| Displayed parameter pairs | Z/ε, Y/ε, Cs/D, Cs/Rs, Cp/D, Cp/Rp, Cp/G | |

Inductance (simulated in 4TP mode only)

| | | |
|----------------------------|---|--------------------------------|
| Range | 10 μH pF to 10 H | fix decimal values in 4TP mode |
| Deviation to nominal value | < 15 % | |
| Calibration uncertainty | 0.1 % to 4 % at 1 kHz depending on value and mode | |
| Temperature coefficient | 50 ppm/°C max. | |
| Displayed parameter pairs | Z/ε, Y/ε, Ls/Q, Ls/Rs | |

Test level meter

| | |
|---------------------------|--|
| Displayed values | frequency, test voltage, test current |
| Frequency range | 20 Hz to 100 kHz |
| Test frequency resolution | 6 digit |
| Test frequency accuracy | 0.01% +1 ms |
| Test voltage range | 200 mV to 10 V RMS |
| Test voltage resolution | 4 digits |
| Test voltage accuracy | 5 % in range 100 mV – 1 V 2 % in range 1 V – 10 V |
| Test current range | 1 nA to 500 mA |
| Test current resolution | 4 digits |

General data

| | |
|-------------------------|-----------------------|
| Interface | RS232, GPIB |
| Reference temperature: | 23 +/- 2 °C, RH < 80% |
| Operating temperatures: | 15 to 30 °C |
| Storage temperatures: | -10 to +40 °C |
| Power line: | 115/230 V – 50/60 Hz |
| Consumption: | 45 VA |

Accuracy parameters

4TP Resistance

| Nominal value Serial resistance R_s | 1 year stability (typical) | Maximal deviation to nominal value at 1 kHz | Calibration uncertainty at 1 kHz | Temperature coefficient (maximal) | Max. test Voltage / Current | Max. resistance deviation 100 kHz |
|--|-------------------------------|---|-------------------------------------|---|--------------------------------|---|
| Ω | % | % | % | %/ $^{\circ}\text{C}$ | V/mA | % |
| 0.1 | 0.001 | 2.00 | 0.20 | 0.0050 | 200 mA | -- |
| 1.0 | 0.001 | 1.00 | 0.10 | 0.0002 | 100 mA | 5.00 |
| 10 | 0.001 | 0.50 | 0.05 | 0.0002 | 50 mA | 0.20 |
| 100 | 0.001 | 0.10 | 0.02 | 0.0002 | 15 mA | 0.03 |
| 1k | 0.001 | 0.10 | 0.02 | 0.0002 | 5 V | 0.05 |
| 10 k | 0.001 | 0.10 | 0.02 | 0.0002 | 15 V | 0.03 |
| 100 k | 0.001 | 0.10 | 0.02 | 0.0002 | 30 V | 0.10 |
| 1 M | 0.003 | 0.10 | 0.03 | 0.0002 | 30 V | -- |
| 10 M | 0.010 | 0.20 | 0.05 | 0.0010 | 30 V | -- |
| 100 M * | 0.010 | 1.00 | 0.50 | 0.0050 | 30 V | -- |

4TP Capacitance

| Nominal value Parallel capacitance C_p | 1 year stability (typical) | Maximal deviation to nominal value at 1 kHz | Calibration uncertainty at 1 kHz | Temperature coefficient (maximal) | Dissipation factor at 1 kHz (typical) | Max. Voltage / Current | Typ. capacitance deviation 100 kHz |
|---|-------------------------------|---|--|---|---|---------------------------|--|
| F | % | % | % | %/ $^{\circ}\text{C}$ | - | V/mA | % |
| 10 p | 0.010 | 0.5 pF | 1.00 | 0.005 | < 0.0020 | 30V | -0.10 |
| 100 p | 0.010 | 5 | 0.10 | 0.005 | < 0.0010 | 30V | -0.02 |
| 1 n | 0.010 | 5 | 0.05 | 0.005 | < 0.0005 | 30V | 0.00 |
| 10 n | 0.010 | 5 | 0.05 | 0.005 | < 0.0005 | 30V | +0.01 |
| 100 n | 0.010 | 5 | 0.05 | 0.005 | < 0.0005 | 20V | +0.03 |
| 1 μ | 0.010 | 5 | 0.05 | 0.005 | < 0.0010 | 10V | +0.20 |
| 10 μ | 0.015 | 5 | 0.10 | 0.010 | < 0.0050 | 100mA | -- |
| 100 μ | 0.015 | 5 | 0.10 | 0.010 | < 0.0200 | 200 mA | -- |

4TP Inductance

| Nominal value Serial inductance L_s | 1 year stability (typical) | Maximal deviation to nominal value at 1 kHz | Calibration uncertainty at 1 kHz | Temperature coefficient (maximal) | Serial resistance R_s (typical) | Max. Voltage / Current | Typ. inductance deviation 100 kHz |
|--|-------------------------------|---|--|---|--------------------------------------|---------------------------|---|
| H | % | % | % | %/ $^{\circ}\text{C}$ | Ω | V/mA | % |
| 10 μ | 0.01 | 15 | 0.30 | 0.005 | 66 | 50 mA | 0.10 |
| 100 μ | 0.01 | 15 | 0.20 | 0.005 | 200 | 30 mA | 0.10 |
| 1 m | 0.01 | 15 | 0.10 | 0.005 | 660 | 5 V / 20 mA | 0.10 |
| 10 m | 0.01 | 15 | 0.10 | 0.005 | 660 | 5 V / 10 mA | 0.10 |
| 100 m | 0.01 | 15 | 0.10 | 0.005 | 2 000 | 10 V | 4.00 |
| 1 | 0.01 | 15 | 0.10 | 0.005 | 20 000 | 10 V | -- |
| 10 | 0.01 | 15 | 0.10 | 0.005 | 20 000 | 10 V | -- |

4W and 2W Resistance

| Nominal value Serial resistance R_s | 1 year stability (typical) | Max. test Voltage / Current | Temperature coefficient (maximal) | 4W mode Maximal deviation to nominal value at 1 kHz | 4W mode Calibration uncertainty at 1 kHz | 2W mode Calibration uncertainty at 1 kHz |
|--|-------------------------------|--------------------------------|---|---|--|--|
| Ω | % | V/mA | %/ $^{\circ}\text{C}$ | % | % | % |
| 0.1 | 0.001 | 200 mA | 0.0050 | 2.0 | 0.50 | -- |
| 1.0 | 0.001 | 500 mA | 0.0002 | 1.5 | 0.10 | 5.0 |
| 10 | 0.001 | 150 mA | 0.0002 | 1.0 | 0.05 | 0.5 |
| 100 | 0.001 | 50 mA | 0.0002 | 1.0 | 0.05 | 0.1 |
| 1k | 0.001 | 10 V | 0.0002 | 1.0 | 0.02 | 0.1 |
| 10 k | 0.001 | 30 V | 0.0002 | 1.0 | 0.02 | 0.1 |
| 100 k | 0.001 | 50 V | 0.0002 | 1.0 | 0.05 | 0.1 |
| 1 M | 0.003 | 50 V | 0.0002 | 1.0 | 0.20 | 0.2 |
| 10 M | 0.010 | 50 V | 0.0010 | 2.0 at 100 Hz | 0.2 at 100 Hz | 0.5 |
| 100 M | 0.010 | 50 V | 0.0025 | 10.0 at 100 Hz | 1.0 at 100 Hz | -- |

4W and 2W Capacitance

| Nominal value Parallel capacitance C_p | 1 year stability (typical) | Temperature coefficient (maximal) | Max. Voltage Current | 4W mode maximal deviation to nominal value at 1 kHz | 4W mode Calibration uncertainty at 1 kHz | 2W mode Calibration uncertainty at 1 kHz |
|---|-------------------------------|--------------------------------------|-------------------------|---|--|--|
| F | % | %/°C | V/mA | % | % | % |
| 100 p | 0.015 | 0.050 | 30V | 10 | 1.0 | 5.0 |
| 1 n | 0.010 | 0.010 | 30V | 10 | 0.10 | 1.0 |
| 10 n | 0.010 | 0.050 | 30V | 10 | 0.05 | 0.2 |
| 100 n | 0.010 | 0.050 | 20V | 10 | 0.05 | 0.2 |
| 1 μ | 0.010 | 0.050 | 10V | 10 | 0.05 | 0.2 |
| 10 μ | 0.015 | 0.010 | 100mA | 10 | 0.10 | 0.5 |
| 100 μ | 0.150 | 0.010 | 200 mA | 10 | 0.20 | 1.0 |

Automation of LCR meter calibration

M550 Impedance calibrator application combines precise and frequency independent partial standards of electric resistance, capacitance and inductance in one housing. It enables both manual and remote control and it is effective tool for manual or automatic adjustments, verifications and calibrations of various types of LCR meters. In 4TP mode the calibrator enables verification of LCR meter in frequency range up to 1 MHz. It offers calibration values either with or without test lead length correction.

Long term stability and comfortness

Excellent long term stability and low temperature coefficient guarantee minimum time shift of calibration values in wide working conditions. Large color front panel display shows calibration values of currently selected partial standard and calibration uncertainty as well. Test level meter can be activated manually offering calibration of test signal voltage and frequency. According to measured frequency calibrator can display calibration values at the measured frequency.

Recalibration procedure

M550 calibration menu offers comfortable recalibration of the calibration data. Two basic method are implemented to make recalibration easier. *Full recalibration* enables access to all stored complex calibration values of all partial standards in spot frequencies. In this way modification of frequency characteristics is fully accessible. *Offset recalibration* simplify process of recalibration to modifying main parameter at 1 kHz frequency only. Difference against the previous calibration value is automatically projected to all spot frequencies.

Correction mode

Calibration data in 4TP mode can be displayed either with or without applied OPEN, SHORT and LOAD correction. OPEN and SHORT corrections enables compensation of test leads residual parameters.

Inductance standards

Inductance standards are available in 4TP coaxial mode only. All partial inductance standards are simulated using passive T type RC network. They can be applied for calibration of LCR meters working on auto-balancing principle. Inductance standards do not contain any wirewound components.

